

**Search Notes**

Application/Control No.

10/767,775

Examiner

Brian Young

Applicant(s)/Patent under  
Reexamination

MILLER, KEVIN LEE

Art Unit

2819

**SEARCHED**

Class	Subclass	Date	Examiner
341	144	2/17/2005	BY
↓	143	↓	BY
↓	155	↓	BY
↓	164	↓	BY
↓	67	↓	BY
↓	65	↓	BY
375	371	↓	BY
↓	372	↓	BY
↓	373	↓	BY
↓	377	↓	BY
↓	293	↓	BY
↓	294	↓	BY
370	505	↓	BY
//	503	↓	BY

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
341	144	2/17/05	BKy

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST JPO<EPO<DERWENT NPL<IEEE<GLOBAL	2/17/2005	BY